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Application/Control	No.	_

10/040,632 Examiner

Afsar M. Qureshi

Applicant(s)/Patent under Reexamination

KANG ET AL.

Art Unit

2616

SEARCHED			
Class	Subclass	Date	Examiner
370	230231	11/8/2006	AQ
	335-338		
	345,442		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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Text, IEEE, NPL, JPO, EPO,DER	11/7/2006	AQ	
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